SN54AC563 ... J OR W PACKAGE

SN74AC563 . . . DB, DW, N, OR PW PACKAGE

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- 3-State Inverting Outputs Drive Bus Lines Directly
- Full Parallel Access for Loading
- Flow-Through Architecture to Optimize PCB Layout
- *EPIC*[™] (Enhanced-Performance Implanted CMOS) 1-μm Process
- Package Options Include Plastic Small-Outline (DW), Shrink Small-Outline (DB), Thin Shrink Small-Outline (PW), Ceramic Chip Carriers (FK) and Flatpacks (W), and Standard Plastic (N) and Ceramic (J) DIPs

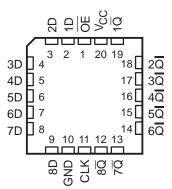
description

The 'AC563 are octal D-type transparent latches with 3-state outputs. When the latch-enable (LE) input is high, the \overline{Q} outputs follow the complements of the data (D) inputs. When LE is taken low, the \overline{Q} outputs are latched at the inverse logic levels set up at the D inputs.

A buffered output-enable (\overline{OE}) input can be used to place the eight outputs in either a normal logic state (high or low logic levels) or the high-impedance state. In the high-impedance state, the outputs neither load nor drive the bus lines significantly. The high-impedance state and increased drive provide the capability to drive bus lines without need for interface or pullup components.

(TOP VIEW)										
OE [1D [2D [3D [4D [5D [7D [8D [1 2 3 4 5 6 7 8 9	20 19 18 17 16 15 14 13 12								
GND [10	11	LE							

SN54AC563 . . . FK PACKAGE (TOP VIEW)



OE does not affect internal operations of the latches. Old data can be retained or new data can be entered while the outputs are in the high-impedance state.

The SN54AC563 is characterized for operation over the full military temperature range of -55° C to 125° C. The SN74AC563 is characterized for operation from -40° C to 85° C.

	(each latch)											
	INPUTS	OUTPUT										
OE	LE	D	Q									
L	Н	Н	L									
L	Н	L	н									
L	L	Х	\overline{Q}_0									
н	Х	Х	z									

ELINCTION TABLE



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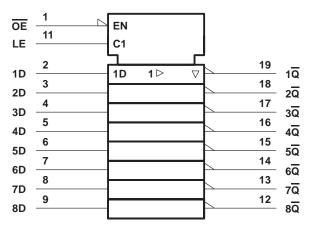
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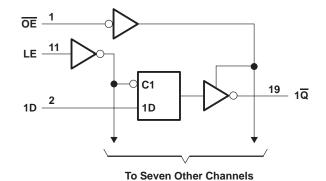
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logic symbol[†]



logic diagram (positive logic)



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[‡]

Supply voltage range, V _{CC} Input voltage range, V _I (see Note 1)	
Output voltage range, V _O (see Note 1)	
Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{CC}$)	±20 mA
Output clamp current, I_{OK} (V _O < 0 or V _O > V _{CC})	±20 mA
Continuous output current, $I_O (V_O = 0 \text{ to } V_{CC})$	±50 mA
Continuous current through V _{CC} or GND	±200 mA
Maximum power dissipation at $T_A = 55^{\circ}C$ (in still air) (see Note 2):	DB package 0.6 W
	DW package 1.6 W
	N package 1.3 W
	PW package 0.7 W
Storage temperature range, T _{stg}	–65°C to 150°C

Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

2. The maximum package power dissipation is calculated using a junction temperature of 150°C and a board trace length of 750 mils, except for the N package, which has a trace length of zero.



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recommended operating conditions (see Note 3)

			SN54A	SN54AC563 SN74AC563		SN54AC563 SN74AC		
			MIN	MAX	MIN MAX		UNIT	
VCC	Supply voltage		2	6	2	6	V	
		V _{CC} = 3 V	2.1		2.1			
VIH	High-level input voltage	$V_{CC} = 4.5 V$	3.15		3.15		V	
		V _{CC} = 5.5 V	3.85		3.85			
		V _{CC} = 3 V		0.9		0.9		
VIL		$V_{CC} = 4.5 V$		1.35		1.35	V	
		V _{CC} = 5.5 V		1.65		1.65		
VI	Input voltage		0	VCC	0	VCC	V	
VO	Output voltage		0	VCC	0	VCC	V	
		V _{CC} = 3 V	PO.	-12		-12		
IOH	High-level output current	V _{CC} = 4.5 V	Q	-24		-24	mA	
		V _{CC} = 5.5 V		-24		-24		
		V _{CC} = 3 V		12		12		
IOL	Low-level output current	$V_{CC} = 4.5 V$		24		24	mA	
		V _{CC} = 5.5 V		24		24		
$\Delta t / \Delta v$	Input transition rise or fall rate			8		8	ns/V	
ТА	Operating free-air temperature		-55	125	-40	85	°C	

NOTE 3: Unused inputs must be held high or low to prevent them from floating.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DADAMETED	TEST CONDITIONS	V	Г	A = 25°C	;	SN54A	C563	SN74A	C563	LINUT
PARAMETER	TEST CONDITIONS	Vcc	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
		3 V	2.99			2.9		2.9		
	I _{OH} = -50 μA	4.5 V	4.49			4.4		4.4		
		5.5 V	5.49			5.4		5.4		
∨он	$I_{OH} = -12 \text{ mA}$	3 V	2.56			2.48		2.46		V
	1011 - 24 mA	4.5 V	3.86			3.8	W	3.76		
	I _{OH} = -24 mA	5.5 V	4.86			4.8	VIE	4.76		
	$I_{OH} = -75 \text{ mA}^{\dagger}$	5.5 V				3.85	RE	3.85		
	I _{OL} = 50 μA	3 V		0.002	0.1	4	0.1		0.1	
		4.5 V		0.001	0.1	$\mathcal{D}_{\mathcal{D}_{\mathcal{C}}}$	0.1		0.1	
		5.5 V		0.001	0.1	201	0.1		0.1	
VOL	I _{OL} = 12 mA	3 V			0.36	6	0.5		0.44	V
	lot = 24 mA	4.5 V			0.36		0.5		0.44	
	I _{OL} = 24 mA	5.5 V			0.36		0.5		0.44	
	$I_{OL} = 75 \text{ mA}^{\dagger}$	5.5 V					1.65		1.65	
li li	$V_I = V_{CC}$ or GND	5.5 V			±0.1		±1		±1	μΑ
IOZ	$V_{O} = V_{CC}$ or GND	5.5 V			±0.5		±5		±5	μA
ICC	$V_{I} = V_{CC} \text{ or } GND, \qquad I_{O} = 0$	5.5 V			8				80	μA
Ci	$V_{I} = V_{CC}$ or GND	5 V		4.5						pF

[†] Not more than one output should be tested at a time, and the duration of the test should not exceed 10 ms.



SN54AC563, SN74AC563 OCTAL D-TYPE TRANSPARENT LATCHES WITH 3-STATE OUTPUTS SCAS552A – NOVEMBER 1995 – REVISED MAY 1996

timing requirements over recommended operating free-air temperature range, V_{CC} = 3.3 V \pm 0.3 V (unless otherwise noted) (see Figure 1)

		T _A = 25°C		SN54AC563 SN74AC563			UNIT
		MIN	MAX		MIN	MAX	UNIT
tw	Pulse duration, LE high	6		80	7		ns
t _{su}	Setup time, data before LE \downarrow	2.5		14	3		ns
t _h	Hold time, data after LE \downarrow	2		23	2		ns

timing requirements over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted) (see Figure 1)

		T _A = 25°C		SN54AC563 SN74AC563		UNIT	
		MIN	MAX		MIN	MAX	UNIT
tw	Pulse duration, LE high	4		6	5		ns
t _{su}	Setup time, data before LE \downarrow	2		4.5	2.5		ns
th	Hold time, data after LE \downarrow	2		2 3	2		ns

switching characteristics over recommended operating free-air temperature range, V_{CC} = 3.3 V \pm 0.3 V (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то	T,	ק = 25°C	;	SN54A	C563	SN74A	C563	UNIT
PARAMETER	(INPUT)	(OUTPUT)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
^t PLH	D		3.5	5.3	13	1.5	16.5	3.5	15	ns
^t PHL	D	Q	3.5	5.6	12	1.5	15.5	3.5	14	115
^t PLH	LE	Q	3.5	4.6	13	1.5	16.5	3.5	15	ns
^t PHL		LE	Q	3.5	4.8	12	1.5	2 15.5	3.5	14
^t PZH	OE	Q	2.5	5.3	11	1.5	13.5	2.5	12	-
^t PZL	OE	Q	3	5.4	11	1.5	14	3.5	12.5	ns
^t PHZ	OE	ā	4	6	12.5	A 1.5	15	4.5	13.5	20
^t PLZ	UE UE	Q	2	5.1	9.5	1.5	12	2.5	10.5	ns

switching characteristics over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то	T,	₄ = 25°C	;	SN54A	C563	SN74A	C563	UNIT
PARAMETER	(INPUT)	(OUTPUT)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
^t PLH	D	<u>a</u> –	2	5.3	10	1.5	13	2	11.5	ns
^t PHL	D		2	5.6	9.5	1.5	12.5	2	11	115
^t PLH	LE	Q	2	4.6	9.5	1.5	12.5	2	11	ns
^t PHL	LL	Q	2	4.8	8.5	1.5	2 11.5	2	9.5	115
^t PZH		ā	2	5.3	9	1.5	11.5	2	10	20
^t PZL	OE	Q	1.5	5.4	8.5	1.5	11	2	9.5	ns
^t PHZ	ŌĒ	Q	2	6	11	X 1.5	13.5	2	12	00
^t PLZ	UE	Q	1.5	5.1	8	1.5	10.5	1.5	9	ns

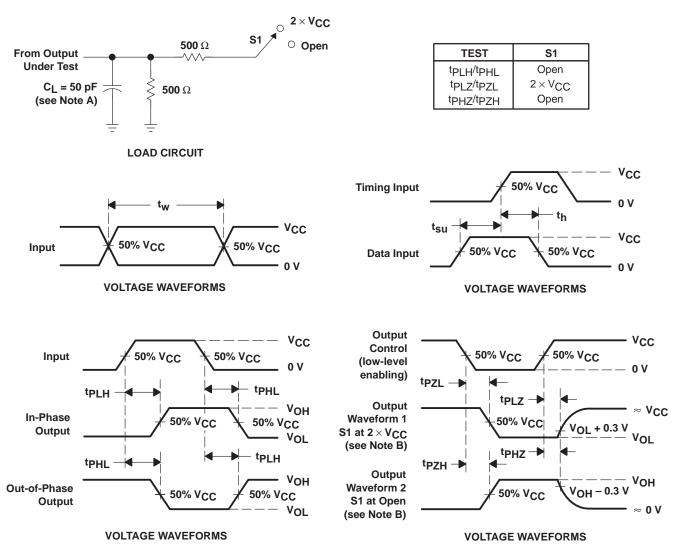
operating characteristics, V_{CC} = 5 V, T_A = 25° C

PARAMETER		TEST COND	TYP	UNIT	
C _{pd}	Power dissipation capacitance	C _L = 50 pF,	f = 1 MHz	25	pF

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PARAMETER MEASUREMENT INFORMATION

NOTES: A. Cl includes probe and jig capacitance.

B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control.

- Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, Z_O = 50 Ω , t_r \leq 2.5 ns, t_f \leq 2.5 ns.

D. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



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